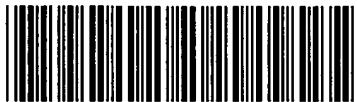


Search Notes**Application/Control No.**

10/633,594

Examiner

Brian Q. Le

Applicant(s)/Patent under Reexamination

FUJII ET AL.

Art Unit

2624

SEARCHED

Class	Subclass	Date	Examiner
382	141, 142 143, 144 145, 146	10/13/06	BL
	147, 148		
	149, 150		
	151, 152		
348	86-87 92, 94, 95	10/13/06	BL
	125-137		
	140-141 143-147		

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST (print out)	10/13/06	BL
IN VENTOR Search (printout) Double Patent Search		
I.E.E.E (print out)		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner